

<b>Notice of References Cited</b>	Application/Control No. 10/588,755		Applicant(s)/Patent Under Reexamination BEN-DAVID ET AL.	
	Examiner ILANA SPAR		Art Unit 2629	Page 1 of 1

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*	C	US-5,896,178	04-1999	Inoue, Tsuyoshi	348/453
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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